Understanding the stable range of equivalent series resistance of an LDO regulator

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This application note explores the stable range of equivalent series resistance (ESR) values for LDO regulators. An ac model of an LDO regulator is presented to discuss the LDO frequency response. Both stable and unstable ESR ranges are examined.

An ac model of an LDO regulator

Figure 1 shows the essential elements of a PMOS LDO regulator. The LDO regulator can be partitioned into four separate and distinct functional blocks—the pass element, the reference, the sampling resistor, and the error amplifier. The error amplifier is modeled by a transconductor (g_a) with a load comprised of capacitor C_{par} and resistor R_{par}. The parasitic param-

Here (C_{par}, R_{par}) represent both the output impedance of the error amplifier and the input impedance of the series pass element. The series pass element (PMOS transistor) is modeled by a small signal model with transconductance g_p . An output capacitor C_o with an equivalent series resistor (R_{ESR}) and a bypass capacitor C_b are added.

From Figure 1, the output impedance is given by

$$Z_{o} = R_{12p} \left\| \left(R_{ESR} + \frac{1}{SC_{o}} \right) \right\| \frac{1}{SC_{b}}$$
(1)
$$= \frac{R_{12p} (1 + SR_{ESR}C_{o})}{S^{2}R_{12p}R_{ESR}C_{o}C_{b} + S[(R_{12p} + R_{ESR})C_{o} + R_{12p}C_{b}] + 1},$$

where
$$R_{12p} = R_{ds} || (R1 + R2) \approx R_{ds}.$$
 (2)

Typically, the output capacitor value C_o is considerably larger than the bypass capacitor C_b . Thus, the output



impedance Z_{o} approximates to

$$Z_{o} \approx \frac{R_{ds}(1 + SR_{ESR}C_{o})}{[1 + S(R_{ds} + R_{ESR})C_{o}] \times [1 + S(R_{ds} ||R_{ESR})C_{b}]}.$$
 (3)

From Equation 3, a part of the overall open-loop transfer function for the regulator is obtained, and the zero and poles can be found. The first pole is

$$P_{o}; S(R_{ds} + R_{ESR})C_{o} = -1$$
 (4)

$$\therefore f_{po} = \frac{-1}{2\pi(R_{ds} + R_{ESR})C_o} \approx \frac{-1}{2\pi R_{ds}C_o} (\because R_{ds} \gg R_{ESR}).$$
(5)

The second pole is obtained from Equation 3 again:

$$P_{b}; \quad S(R_{ds} \| R_{ESR}) C_{b} = -1$$
(6)

$$\therefore f_{pb} = \frac{-1}{2\pi (R_{ds} \| R_{ESR}) C_b} \approx \frac{-1}{2\pi R_{ESR} C_b}.$$
 (7)

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The zero is

$$Z_{\text{ESR}}; \quad \text{SR}_{\text{ESR}}C_{0} = -1$$
 (8)

$$\therefore f_{Z(ESR)} = \frac{-1}{2\pi R_{ESR}C_o}.$$
 (9)

In addition, another pole exists from the input impedance of the pass element (i.e., the output impedance of the amplifier, R_{par} , C_{par}). The approximated poles and the zero of the LDO regulator are then given by

$$P_{o} \approx \frac{1}{2\pi R_{ds}C_{o}} \approx \frac{I_{L}}{2\pi V_{A}C_{o}},$$
(10)

$$P_{\rm b} \approx \frac{1}{2\pi R_{\rm ESR} C_{\rm b}},\tag{11}$$

$$P_a \approx \frac{1}{2\pi R_{par}C_{par}}$$
, and (12)

$$Z_{\rm ESR} \approx \frac{1}{2\pi R_{\rm ESR} C_{\rm o}},$$
 (13)

where $R_{ds}\approx V_A/I_L, V_A=1/\lambda$ for MOS device, and λ is the channel-length modulation parameter. Pole P_a is the only one introduced at the input of the pass device, not at the output of the device. Based upon the derived poles and zero, the typical frequency response of the LDO regulator is obtained and is shown in Figure 2. Pole P_o depends on the load current. When load current is low, a pole response occurs at relatively low frequencies, thereby degrading phase margin. Worst-case of stability arises at the extreme values of the ESR and at low load currents.



Figure 3. LDO frequency response without compensation

Figure 2. Typical frequency response of the LDO voltage regulator



Range of stable ESR

An LDO regulator would require an output capacitor with an output equivalent series resistor (ESR) to stabilize the control loop. As shown in Figure 3, an LDO has two poles that cause instability if it is not compensated. It is obvious that the linear regulator is unstable because the phase shift at unity gain frequency (UGF) is -180° (i.e., phase margin = 0°) due to the effects of two poles (P_o, P_a) at low

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frequencies. To make the regulator stable, a zero must be added, which will cancel out the phase effect of one of two poles.

The ESR of an output capacitor or a compensated series resistor (CSR) is used for the zero. Figure 4 shows how the ESR (or CSR) zero stabilizes the control loop. The zero produced by the ESR locates before UGF so that the phase margin at UGF₁ will be higher than 0°. Thus, the linear regulator becomes stable. The phase margin of the control loop at UGF always should be more than 0° for the system stability.

The ESR value should be maintained in the range that determines the loop stability. In most cases, LDO regulators have the minimum/maximum ESR values. Figures 5 and 6 show that the loop responses are unstable even though a zero is added. From Equations 11 and 13, the zero $\rm Z_{esr}$ and the pole $\rm P_b$ are determined by the ESR. When the ESR changes, $\rm Z_{esr}$ and $\rm P_b$ are shifted upward/downward and the loop stability is affected.

Figure 5 illustrates the unstable frequency response of LDO when the ESR is too high, and Figure 6 illustrates the LDO frequency response when the ESR is too low. For both cases, the phase margin at UGF is less than or equal to 0°, resulting in system instability. Figures 5 and 6 show the stable range of $Z_{\rm esr}$.

Since ESR can cause instability, LDO manufacturers typically provide a graph showing the stable range of ESR values. Figure 7 shows a typical range of ESR values with respect to the output currents (TI TPS76933, 3.3-V LDO regulator). This curve is called the "Tunnel of Death." The curve shows that ESR must be between 0.1 Ω and 8 Ω . Solid tantalum electrolytic, aluminum electrolytic, and multilayer ceramic capacitors are all suitable, provided they meet the ESR requirements.



Figure 6. Unstable frequency response of LDO with ESR too low

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Figure 5. Unstable frequency response of LDO with ESR too high



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Figure 7. Range of stable ESR values

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